

IEC QUALITY ASSESSMENT SYSTEM (IECQ)

covering Electronic Components, Assemblies, Related Materials and Processes

For rules and details of the IECQ visit www.iecq.org

Schedule of Scope to Certificate of Conformity

Independent Testing Laboratory

IECQ Certificate No.: IECQ-L ULTW 22.0005

CB Certificate No.: 20005220 ITL

Schedule Number: IECQ-L ULTW 22.0005-S Rev No.: 1 Revision Date: 2022/10/03 Page 1 of 1

Appendix-1 (20005220 ITL) Schedule of Scope to Certificate of Approval

Test Items	Standard/Method
IV Curve	Q-ANC02-3-032
Probing test	Q-ANC02-3-032
Time Domain Reflectometry (TDR)	Q-ANC02-3-046
Scanning Acoustic Tomography (SAT)	Q-FMM03-3-024
Focused Ion Beam microscope (FIB)	Q-ANC02-3-037
Scanning Electron Microscope (SEM)	Q-FAS01-3-026

Technical Reviewer of DQS: Michael Chou Date: 10/03/2022

